

# **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

# **OptiMOS**<sup>™</sup>

OptiMOS<sup>™</sup> Power-Transistor, 60 V IPD025N06N

# **Data Sheet**

Rev. 2.5 Final



IPD025N06N

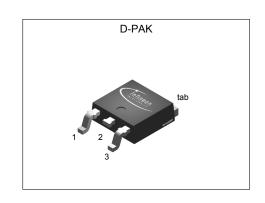
#### 1 **Description**

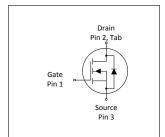
### **Features**

- Optimized for synchronous rectification
- 100% avalanche tested
- Superior thermal resistance
- N-channel, normal level
- Qualified according to JEDEC<sup>1)</sup> for target applications
  Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21



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Parameter	Value	Unit					
<b>V</b> <sub>DS</sub>	60	V					
R <sub>DS(on),max</sub>	2.5	mΩ					
$I_{D}$	90	A					
Qoss	81	nC					
Q <sub>G</sub> (0V10V)	71	nC					











Type / Ordering Code	Package	Marking	Related Links
IPD025N06N	PG-TO252-3	025N06N	-



## IPD025N06N

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**2 Maximum ratings** at  $T_j = 25$  °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	0 b a l	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I <sub>D</sub>	- - -	-	90 90 26	A	V <sub>GS</sub> =10 V, T <sub>C</sub> =25 °C V <sub>GS</sub> =10 V, T <sub>C</sub> =100 °C V <sub>GS</sub> =10 V, T <sub>C</sub> =25 °C, R <sub>thJA</sub> =50K/W
Pulsed drain current <sup>1)</sup>	I <sub>D,pulse</sub>	-	-	360	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche energy, single pulse <sup>2)</sup>	<b>E</b> AS	-	-	210	mJ	$I_{\rm D}$ =90 A, $R_{\rm GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	167 3.0	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =50 K/W
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

#### 3 Thermal characteristics

Table 3 Thermal characteristics

Doromotor	Symbol	Values			l lmi4	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R <sub>thJC</sub>	-	0.5	0.9	K/W	-	
Device on PCB, minimal footprint	R <sub>thJA</sub>	-	-	62	K/W	-	
Device on PCB, 6 cm² cooling area <sup>3)</sup>	R <sub>thJA</sub>	-	-	40	K/W	-	
Soldering temperature, wave and reflow soldering are allowed	$T_{sold}$	-	-	260	°C	Reflow MSL1	

See figure 3 for more detailed information
 See figure 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



## 4 Electrical characteristics

**Table 4** Static characteristics

Davamatav	Cymahal		Values			Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	$V_{(BR)DSS}$	60	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	2.1	2.8	3.3	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=95\ \mu{\rm A}$	
Zero gate voltage drain current	$I_{ m DSS}$	-	0.5 10	1 100	μA	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	2.1 2.7	2.5 3.8	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =90 A V <sub>GS</sub> =6 V, I <sub>D</sub> =22.5 A	
Gate resistance <sup>1)</sup>	R <sub>G</sub>	-	1.7	2.6	Ω	-	
Transconductance	<b>g</b> fs	80	160	-	S	$ V_{DS}  > 2 I_D R_{DS(on)max}, I_D = 90 A$	

Table 5 Dynamic characteristics<sup>1)</sup>

Danamatan	Ole al		Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	5200	6500	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz	
Output capacitance	Coss	-	1200	1500	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz	
Reverse transfer capacitance	C <sub>rss</sub>	_	48	96	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz	
Turn-on delay time	$t_{\sf d(on)}$	-	16	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =90 A, $R_{\rm G,ext}$ ,ext=1.6 $\Omega$	
Rise time	t <sub>r</sub>	-	20	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =90 A, $R_{\rm G,ext}$ ,ext=1.6 $\Omega$	
Turn-off delay time	$t_{ m d(off)}$	-	34	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =90 A, $R_{\rm G,ext}$ ,ext=1.6 $\Omega$	
Fall time	t <sub>f</sub>	-	12	-	ns	$V_{\rm DD} = 30 \text{ V}, V_{\rm GS} = 10 \text{ V}, I_{\rm D} = 90 \text{ A}, R_{\rm G,ext}, \text{ext} = 1.6 \Omega$	



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Gate charge characteristics<sup>1)</sup> Table 6

Downwater	Cymahal	Values			11::4	Nata / Tank Candition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Gate to source charge	Q <sub>gs</sub>	-	24	-	nC	$V_{DD}$ =30 V, $I_{D}$ =90 A, $V_{GS}$ =0 to 10 V	
Gate charge at threshold	Q <sub>g(th)</sub>	-	14	-	nC	$V_{DD}$ =30 V, $I_{D}$ =90 A, $V_{GS}$ =0 to 10 V	
Gate to drain charge <sup>2)</sup>	Q <sub>gd</sub>	-	13	17	nC	V <sub>DD</sub> =30 V, I <sub>D</sub> =90 A, V <sub>GS</sub> =0 to 10 V	
Switching charge	Q <sub>sw</sub>	-	23	-	nC	$V_{DD}$ =30 V, $I_{D}$ =90 A, $V_{GS}$ =0 to 10 V	
Gate charge total	Qg	-	71	83	nC	$V_{DD}$ =30 V, $I_{D}$ =90 A, $V_{GS}$ =0 to 10 V	
Gate plateau voltage	<b>V</b> <sub>plateau</sub>	-	4.7	-	V	$V_{DD}$ =30 V, $I_{D}$ =90 A, $V_{GS}$ =0 to 10 V	
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	62	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V	
Output charge <sup>2)</sup>	Qoss	-	81	102	nC	V <sub>DD</sub> =30 V, V <sub>GS</sub> =0 V	

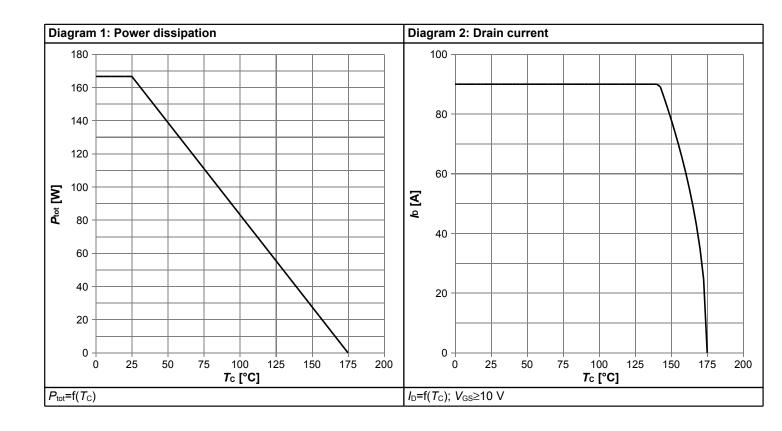
#### Table 7 Reverse diode

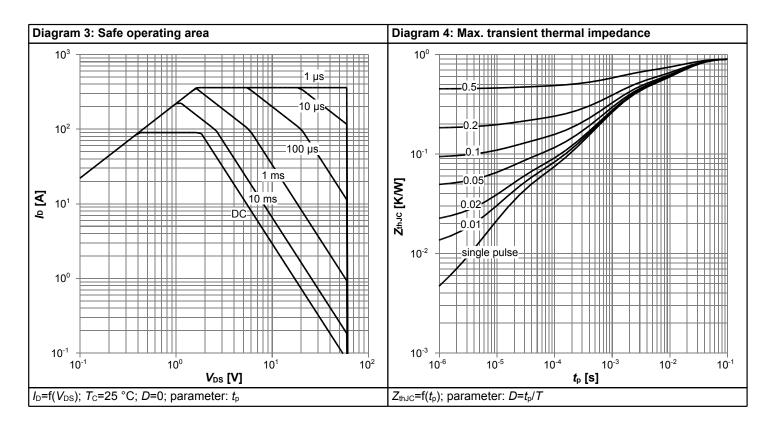
Parameter	Symbol	Values			Unit	Note / Test Condition	
Faranietei	Syllibol	Min. Typ. Max.		Note / Test Condition			
Diode continuous forward current	I <sub>s</sub>	-	-	90	Α	T <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	360	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode forward voltage	V <sub>SD</sub>	-	1.0	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =90 A, T <sub>j</sub> =25 °C	
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	-	83	133	ns	$V_R$ =30 V, $I_F$ = $I_S$ , $di_F/dt$ =100 A/ $\mu$ s	
Reverse recovery charge	Qrr	-	105	-	nC	$V_R$ =30 V, $I_F$ = $I_S$ , $di_F$ / $dt$ =100 A/ $\mu$ s	

 $<sup>^{1)}</sup>$  See "Gate charge waveforms" for parameter definition  $^{2)}$  Defined by design. Not subject to production test

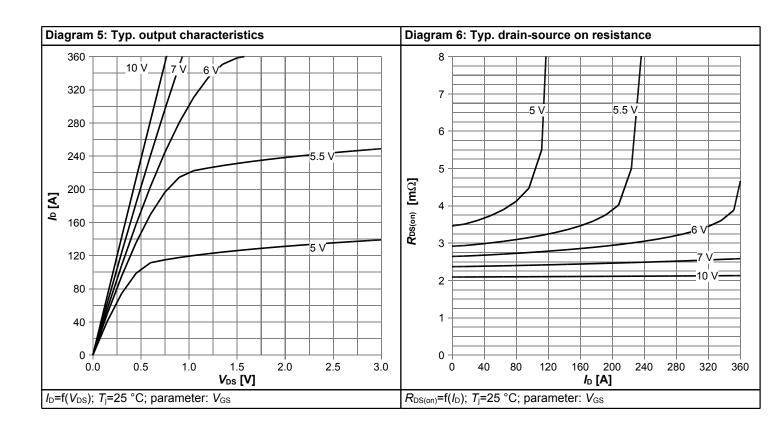


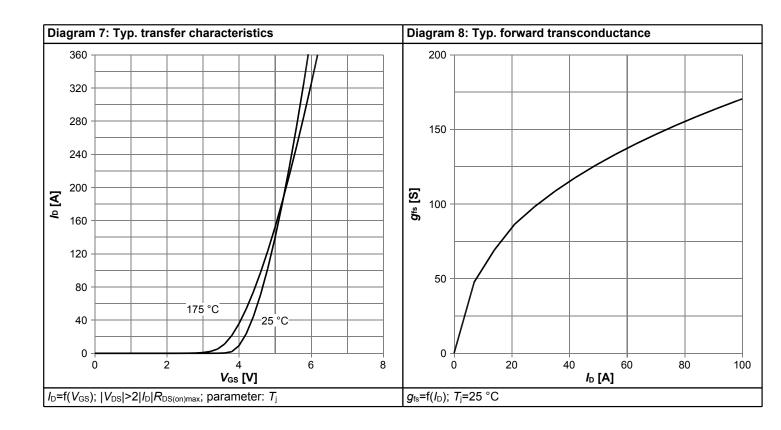
## 5 Electrical characteristics diagrams



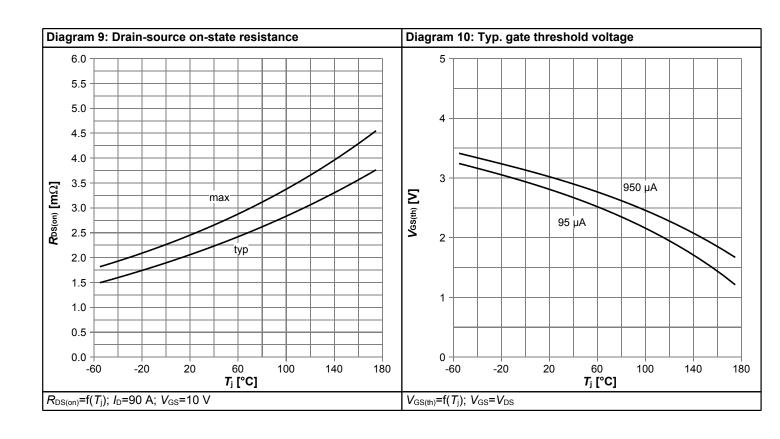


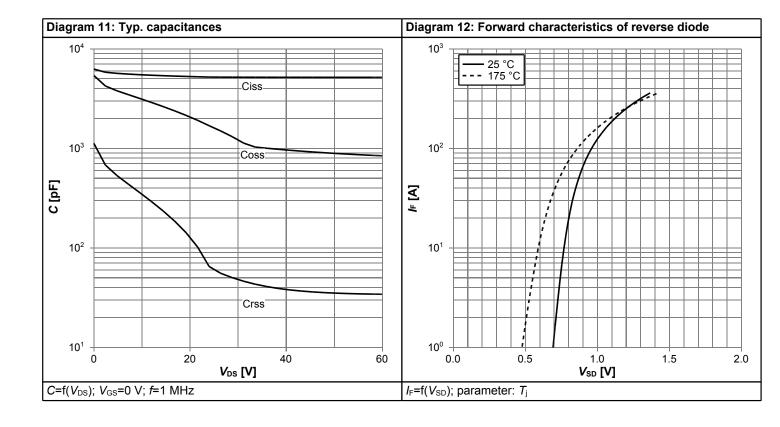




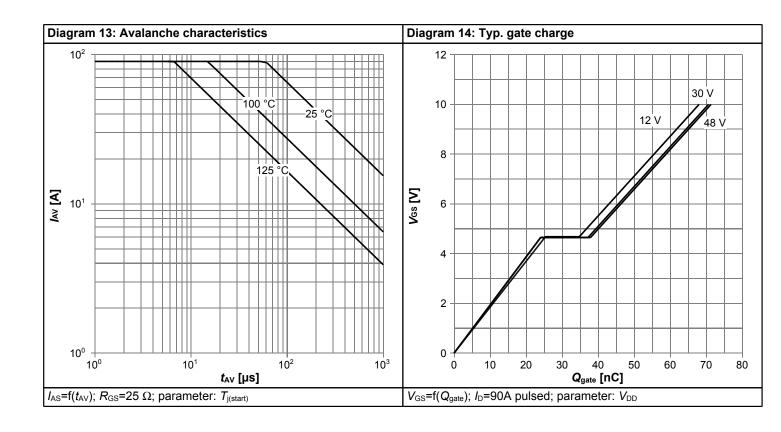


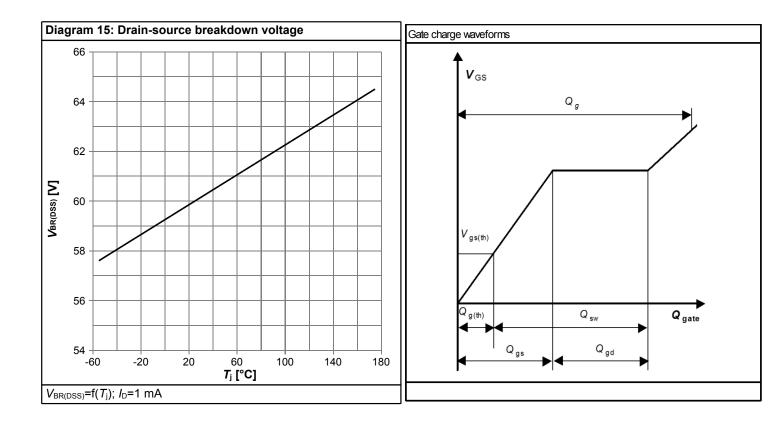






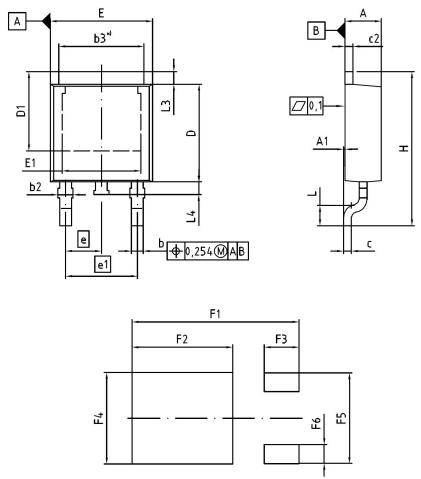








## 6 Package Outlines



\*) mold flash not included

DIM	MILLIN	IETERS	INCHES		
DIW	MIN	MAX	MIN	MAX	
Α	2.16	2,41	0.085	0.095	
A1	0.00	0.15	0.000	0.006	
b	0.64	0.89	0.025	0.035	
b2	0.65	1.15	0.026	0.045	
b3	5.00	5.50	0.197	0.217	
С	0.46	0.60	0.018	0.024	
c2	0.46	0.98	0.018	0.039	
D	5.97	6.22	0.235	0.245	
D1	5.02	5.84	0.198	0.230	
Е	6.40	6.73	0.252	0.265	
E1	4.70	5.21	0.185	0.205	
е	2	.29 (BSC)	0.090 (BSC)		
e1	4.	.57	0.1	80	
N		3	3		
H	9.40	10.48	0.370	0.413	
١	1.18	1.70	0.046	0.067	
L3	0.90	1.25	0.035	0.049	
L4	0.51	1.00	0.020	0.039	
F1	10	.60	0.4	117	
F2	6	.40	0,252		
F3	2	.20	0.087		
F4	5	.80	0.228		
F5	5	.76	0.2	227	
F6	1.	.20	0.0	)47	

SCALE 0
2.0
4mm

EUROPEAN PROJECTION

ISSUE DATE
16-02-2011

REVISION
04

Figure 1 Outline PG-TO252-3, dimensions in mm/inches



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### **Revision History**

IPD025N06N

Revision: 2014-07-23, Rev. 2.5

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.5	2014-07-23	Rev.2.5

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